

Notice of References Cited	Application/Control No. 10/770,074	Applicant(s)/Patent Under Reexamination HAY, JENNIFER	
	Examiner Toan M. Le	Art Unit 2863	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,357,786	10-1994	Lung et al.	73/81
	B	US-6,134,954	10-2000	Suresh et al.	73/81
	C	US-5,999,887	12-1999	Giannakopoulos et al.	702/33
	D	US-6,247,355	06-2001	Suresh et al.	73/82
	E	US-6,520,004	02-2003	Lin, Li	73/81
	F	US-6,279,388	08-2001	Tsujii et al.	73/82
	G	US-6,311,135	10-2001	Suresh et al.	702/43
	H	US-6,904,806	06-2005	Pryor, Roger W.	73/597
	I	US-6,718,820	04-2004	Kwon et al.	73/81
	J	US-6,851,300	02-2005	Kwon et al.	73/85
	K	US-5,309,754	05-1994	Ernst, Alfred	73/81
	L	US-5,463,896	11-1995	Abbate et al.	73/81
	M	US-4,275,966	06-1981	Kleesattel, Claus	356/626

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Herrmann et al., Progress in Determination of the Area Function of Indenters Used for Nanoindentation, 2000, Thin Solid Films 377-378, Pages 394-400
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.